

**Search Notes**

Application No.

10/046,926

Examiner

Vuthe Siek

Applicant(s)

TEIG ET AL.

Art Unit

2825

**SEARCHED**

Class	Subclass	Date	Examiner
716	12-15	1/12/2004	VS
Same as above 11/8/04 VS			

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST ALL DATABASES	1/12/2004	VS
same + IEEE	11/8/04	VS